**AP4951GM** 

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>d, e</sup>	Q <sub>g</sub> (Тур.)		
- 60	0.059 at V <sub>GS</sub> = - 10 V	- 5.3	17 nC		
- 00	0.069 at V <sub>GS</sub> = - 4.5 V	- 5.0	17110		

#### **FEATURES**

Dual P-Channel 60-V (D-S) MOSFET

- Halogen-free
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % UIS Tested

#### APPLICATIONS

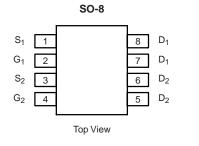
Load Switches

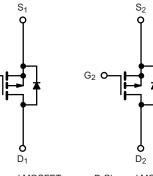


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P-Channel MOSFET

G1 0

P-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b>	A = 25 °C, unless othe	erwise noted			
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	- 60	V		
Gate-Source Voltage	V <sub>GS</sub>	± 20			
	T <sub>C</sub> = 25 °C		- 5.3 <sup>e</sup>		
Continuous Drain Current ( $T_1 = 150 \ ^{\circ}C$ )	T <sub>C</sub> = 70 °C		- 5.0 <sup>e</sup>		
Continuous Drain Current (1j = 150°C)	T <sub>A</sub> = 25 °C	<sup>'D</sup>	- 5.3 <sup>a, b</sup>		
	T <sub>A</sub> = 70 °C	1	- 5.0 <sup>a, b</sup>	•	
Pulsed Drain Current	I <sub>DM</sub>	- 32 <sup>e</sup>	Α		
Continuous Course Durin Diada Current	T <sub>C</sub> = 25 °C		- 4.1		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	- 2.0 <sup>a, b</sup>		
Avalanche Current		I <sub>AS</sub>	- 20		
Single-Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	20	mJ	
	T <sub>C</sub> = 25 °C		4.0		
Mariana David Distinction	T <sub>C</sub> = 70 °C		2.5		
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.0 <sup>a, b</sup>		
	T <sub>A</sub> = 70 °C	1 -	1.4 <sup>a, b</sup>		
Operating Junction and Storage Temperature Rang	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>a, c</sup>	t ≤ 10 s	R <sub>thJA</sub>	38	50	°C/W	
Maximum Junction-to-Foot	Steady State	R <sub>thJF</sub>	20	25	C/W	

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

c. Maximum under Steady State conditions is 85 °C/W.

d. Based on T<sub>C</sub> = 25 °C.

e. Limited by package.

SPECIFICATIONS T <sub>J</sub> = 25 °C, unless otherwise noted   Parameter Symbol Test Conditions Min. Typ. Max.						L lucit
	Symbol	Test Conditions	win.	Тур.	wax.	Unit
Static	V	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA	00		1	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$v_{GS} = 0 v, I_D = -230 \mu A$	- 60	0.1		V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	I <sub>D</sub> = - 250 μA		- 31		- mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	<u>)/ )/ 1 250 uA</u>	4.0	4.5		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = -250 \mu A$	- 1.0		- 3.0	V
Gate-Source Leakage	IGSS	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55 \text{ °C}$			- 1 - 5	μA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge$ - 10 V, $V_{GS}$ = - 10 V	- 30			Α
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 6.3 A		0.054		Ω
		$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -6.2 \text{ A}$		0.060		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 6.1 A		23		S
Dynamic <sup>b</sup>	-			1	1	1
Input Capacitance	C <sub>iss</sub>			1345		
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -15 V$ , $V_{GS} = 0 V$ , f = 1 MHz		210		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			180		
Total Gate Charge	Qg	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 6.1 A		32 15	50 25	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 6.1 A		4	20	
Gate-Drain Charge	⊂gs Q <sub>gd</sub>			7.5		
Gate Resistance	∽ga R <sub>g</sub>	f = 1 MHz		5.8		Ω
Turn-On Delay Time	t <sub>d(on)</sub>			10	15	
Rise Time	t <sub>r</sub>	$V_{DD} = -15 \text{ V}, \text{ R}_{1} = 15 \Omega$		8	15	
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -1 \text{ A}, \text{ V}_{\text{GEN}} = -10 \text{ V}, \text{ R}_a = 1 \Omega$		45	70	
Fall Time	t <sub>f</sub>	.D =, .GEN,		12	25	
Turn-On Delay Time	t <sub>d(on)</sub>			42	70	ns
Rise Time	t <sub>r</sub>	$V_{DD} = -15 \text{ V}, \text{ R}_{1} = 15 \Omega$		35	60	-
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -1 \text{ A}, \text{ V}_{\text{GEN}} = -4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		40	70	
Fall Time	t <sub>f</sub>	D CEN g		16	30	
Drain-Source Body Diode Characterist					1	I
Continous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			- 4.1	1
Pulse Diode Forward Current	I <sub>SM</sub>	<u> </u>			- 32	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 2 A, V <sub>GS</sub> = 0 V		- 0.75	- 1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	······································		34	60	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			22	40	nC
Reverse Recovery Fall Time	t <sub>a</sub>	I <sub>F</sub> = - 2 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		11		
Reverse Recovery Rise Time		t <sub>b</sub>		23		ns

Notes:

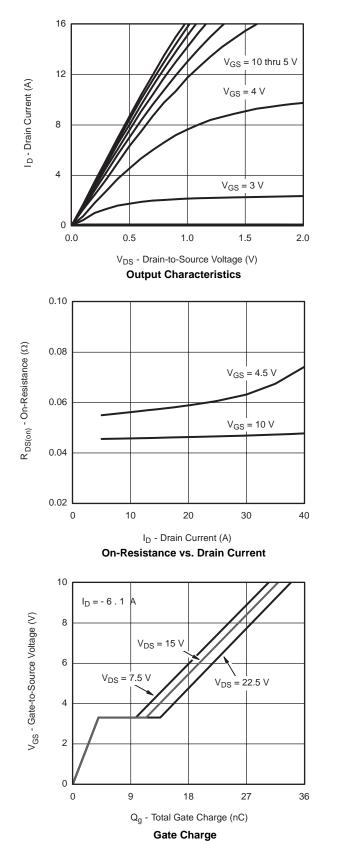
a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

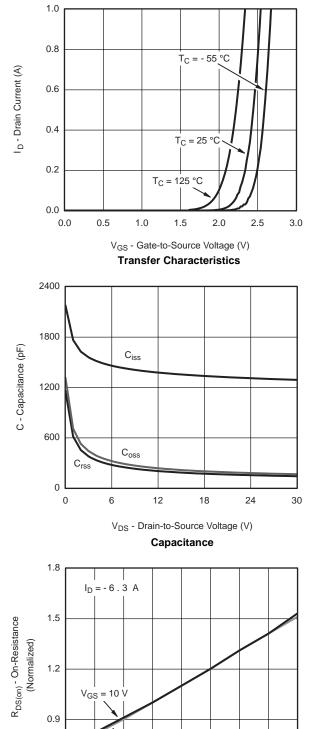
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

emi





#### TYPICAL CHARACTERISTICS 25 C, unless otherwise noted



V<sub>GS</sub> = 4.5 V

25

50

T<sub>J</sub> - Junction Temperature (°C) On-Resistance vs. Junction Temperature

75

100

125 150

0

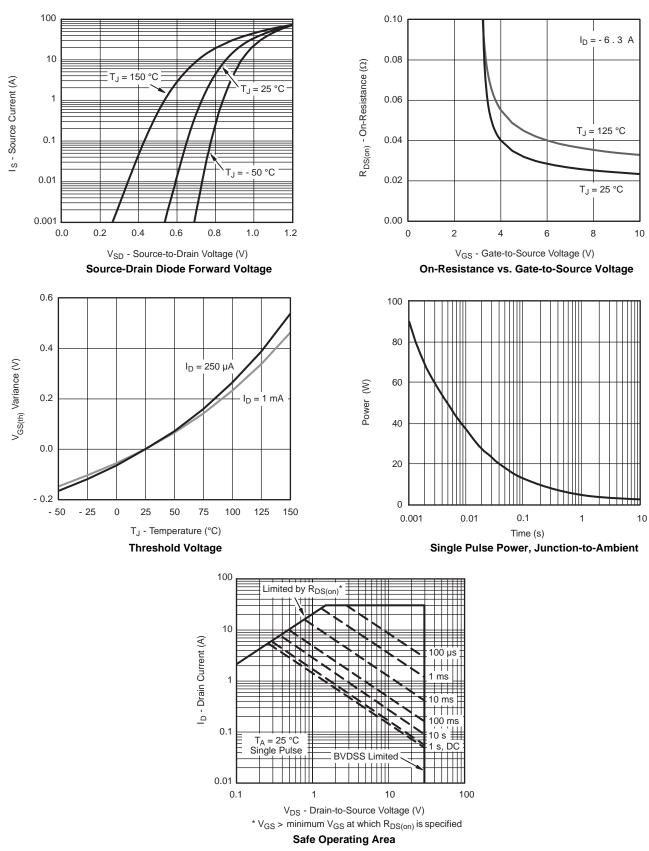
0.6

- 50

- 25

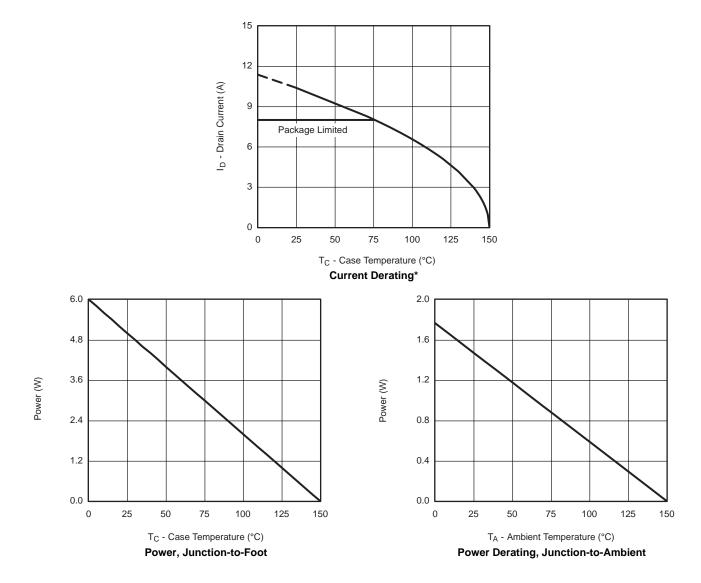








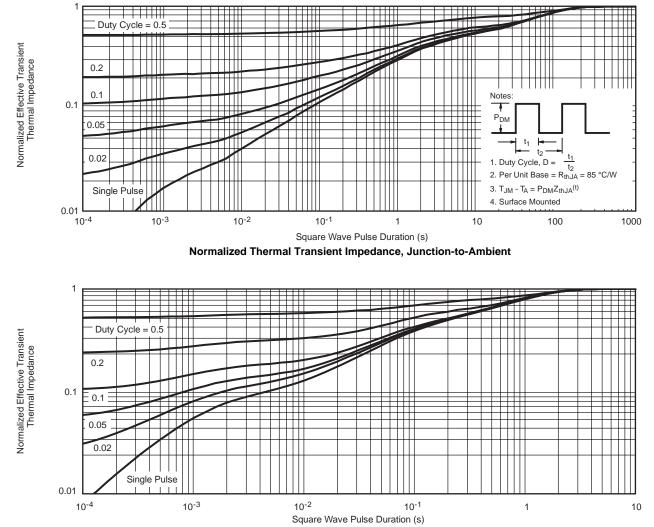
#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



\* The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

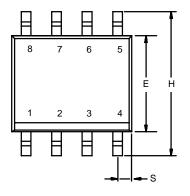


Normalized Thermal Transient Impedance, Junction-to-Foot



### SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012

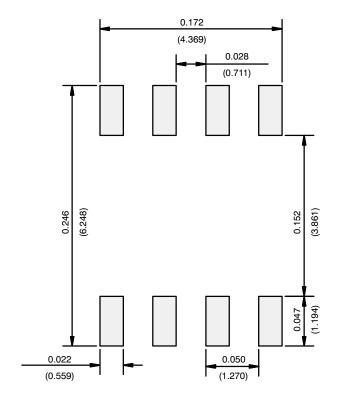




	MILLIM	IETERS	INCHES			
DIM	Min	Мах	Min	Max		
A	1.35	1.75	0.053	0.069		
A <sub>1</sub>	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
E	3.80	4.00	0.150	0.157		
е	1.27 BSC		0.050 BSC			
н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498						



**RECOMMENDED MINIMUM PADS FOR SO-8** 



Recommended Minimum Pads Dimensions in Inches/(mm)



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